## Product Change Notification - JAON-04VUHY153

**Date:** 08 Jun 2016

**Product Category:** SMSC

Notification subject: CCB 1735 Final Notice: Qualification of NSEB as an additional assembly site for selected products

in 16L QFN (5x5x0.9mm) package.

Notification text: PCN Status: Final notification

#### Microchip Parts Affected:

Please open the attachments found in the attachments field below labeled as PCN # Affected CPN.

NOTE: For your convenience Microchip includes identical files in two formats (.pdf and .xls).

#### Description of Change:

Qualification of NSEB as an additional assembly site for selected products in 16L QFN (5x5x0.9mm) package.

#### Pre Change:

Assembled at SCC assembly site using C194 lead-frame, 8290 die attach material, G770 molding compound and Palladium coated copper wire with gold flash (CuPdAu) bond wire.

#### Post Change:

Assembled at NSEB assembly site using EFTEC-64Tlead-frame, 8600 die attach material, G700LTD molding compound and palladium coated copper wire with gold flash (CuPdAu) bond wire.

#### Pre and Post Change Summary:

	Pre Change	Post Change
Assembly Site	SCC assembly site	NSEB assembly site
Wire material	CuPdAu wire	CuPdAu wire
Die attach material	8290	8600
Molding compound material	G770	G700
Lead frame material	C194	EFTEC-64T

#### Impacts to Data Sheet:

None

#### Reason for Change:

To improve on-time delivery performance by qualifying NSEB assembly site. SCC assembly site will no longer have manufacturing support to assemble selected products available in 16L QFN (5x5x0.9mm) package.

#### **Change Implementation Status:**

In Progress

#### **Estimated First Ship Date:**

July 10, 2016 (date code: 1627)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

#### Summary Table:

	September 2015			>	June 2016			July 2016							
WW	36	37	38	39	40		22	23	24	25	26	27	28	29	30
Initial PCN Issue Date					Х										
Qual Report Availability								Х							
Final PCN Issue Date								Х							
Estimated Implementation Date												Х			

#### Markings to Distinguish Revised from Unrevised Devices:

Traceability code

#### **Revision History:**

September 29, 2015: Issued initial notification.

**June 8, 2016.** Issued final notification. Attached the qualification report. Revised the estimated first ship date from January 22, 2016 to July 10, 2016. Updated the post change to only reflect NSEB assembly site. Updated reason for change to emphasize that SCC will no longer have manufacturing support to assemble selected products available in 16L QFN (5x5x0.9mm) package.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

**Attachment(s):** PCN\_JAON-04VUHY153\_Qual\_Report.pdf

PCN\_JAON-04VUHY153\_Affected\_CPN.pdf PCN\_JAON-04VUHY153\_Affected\_CPN.xls

Please contact your local Microchip sales office with questions or concerns regarding this notification.

#### **Terms and Conditions:**

If you wish to change your product/process change notification (PCN) profile please log on to our website at <a href="http://www.microchip.com/PCN">http://www.microchip.com/PCN</a> sign into myMICROCHIP to open the myMICROCHIP home page, then select a profile option from the left navigation bar.

To opt out of future offer or information emails (other than product change notification emails), click here to go to microchipDIRECT and login, then click on the "My account" link, click on "Update profile" and un-check the box that states "Future offers or information about Microchip's products or services."

JAON-04VUHY153 - CCB 1735 Final Notice: Qualification of NSEB as an additional assembly site for selected products in 16L QFN (5x5x0.9mm) package.

Affected Catalog Part Numbers (CPN)

PCN_JAON-04VUHY153
CATALOG_PART_NBR
SEC1100-A5-02
SEC1100-A5-02H1
SEC1100-A5-02NC-TR
SEC1100-A5-02S2
SEC1100-A5-02-TR
SEC1110-1100A5
SEC1110-A5-02
SEC1110-A5-02A1
SEC1110-A5-02A1-TR
SEC1110-A5-02G1
SEC1110-A5-02G1-TR
SEC1110-A5-02NC
SEC1110-A5-02NC-TR
SEC1110-A5-02-TR
SEC1110-A5-03G1
SEC1110-A5-03G1-TR
SEC1110I-A5-02
SEC1110I-A5-02G1
SEC1110I-A5-02G1-TR
SEC1110I-A5-02-TR
USX1011-A5-02



# **QUALIFICATION REPORT**RELIABILITY LABORATORY

**PCN #: JAON-04VUHY153** 

Date: May 31, 2016

Qualification of NSEB as an additional assembly site for selected products in 16L QFN (5x5x0.9mm) package.

Distribution: CORPORATE QA/RE

CORPORATE PACKAGING SUPPLIER ENGINEERING



### **OBJECTIVE**

Qualification of NSEB as an additional assembly site for selected products in 16L QFN (5x5x0.9mm) package.

QUAL ID QAR2015-025 BD # BDM-000885C

PART # XA6011UKXA0C (USX1011-A5-02)

CCB # 1735

## **PRODUCT INFORMATION**

PACKAGE TYPE QFN (SAWN)
PACKAGE LEAD COUNT 16 (5x5X0.9mm)

PACKAGE CODE UKX

MANUFACTUR PART # XA6011UKXA0C (USX1011-A5-02

WAFER LOT TC14915100248.120 WAFER MASK 136021A1 (XA601)

WAFER PROCESS 0.13um

FAB TSD - Fab 14 (TSMC)

CIRCUIT UNDER PAD YES

## **Material used in the Assembly:**

LEADFRAME MATERIAL EFTEC-64T (Double Ring / Etched)

LEADFRAME SURFACE ROUGHENED

LEADLOCK YES
DIE ATTACH EPOXY TYPE 8600
EPOXY – CONDUCTIVE YES

WIRE TYPE CuPdAu MOLDING COMPOUND TYPE G700LTD

LEAD FINISH PROCESS ELECTROPLATING

LEAD FINISH COMPOSITION Matte-Sn MARKING LASER



# **Manufacturing Information**

Assembly Lot No.	Wafer Lot No.	MARKING /Date Code
NSEB162300453.000	P0UK48.00 / TC14915100248.120	USX1011-2 B1536-121 536J4VA AULTH (e3)
NSEB162400003.000	P0UK48.00 / TC14915100248.120	USX1011-2 B1537-121 537J61A AUTLTH (e3)
NSEB162300464.000	POUK48.00 / TC14915100248.120	USX1011-2 B1536-121 536J5QA AUTLTH (e3)

Result	X Pass Fail
	The 16L Sawn QFN (5x5x0.9mm) package using CuPdAu 0.7 mil wire, assembled by NSEB Pass Reliability test per QCI-39000. This package was qualified the Moisture/Reflow Sensitivity Classification Level 3 at 260 ℃ reflow temperature per IPC/JEDEC J-STD-020D standard.
F	Prepared By: Peter Boudouris Date: May 31, 2016 (Corporate Reliability & FA)

Approved By: Vassilios Danginis Date: : May 31, 2016 (Corporate Reliability & FA)

PACKAGE QUALIFICATION REPORT									
Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks			
Moisture/Reflow Sensitivity	30℃/ 60%RH	IPC/	320	0/320	Pass	LOT 1			
Classification	Moisture Soak 192 hrs.	JEDEC	320	0/320	Pass	LOT 2			
Test (At MSL Level 3)	( IPC/JEDEC J-STD-020D)	J-STD- 020D	320	0/320	Pass	LOT 3			

Precondition Prior Perform	Electrical Test :+25 °C and +85 °C	JESD22- A113	320 (0)	320	PASS	Good Devices
Reliability Tests (At MSL Level 3)	SAT		Lot 1	320		
	Bake 125°C, 24 hrs			320		
	30 ℃/60%RH Moisture Soak 192hrs			320		
	3x Convection-Reflow 265 ℃ max			320		
	SAT			320		
	Electrical Test :+25 ℃ and +85 ℃			320	PASS	

Precondition Prior Perform	Electrical Test :+25 °C and +85 °C	JESD22- A113	320 (0)	320	PASS	Good Devices
Reliability Tests (At MSL Level 3)	SAT		Lot 2	320		
	Bake 125℃, 24 hrs			320		
	30 ℃/60%RH Moisture Soak 192hrs			320		
	3x Convection-Reflow 265 ℃ max			320		
	SAT			320		
	Electrical Test :+25 ℃ and +85 ℃			320	PASS	

Precondition Prior Perform	Electrical Test :+25 °C and +85 °C	JESD22- A113	320 (0)	320	PASS	Good Devices
Reliability Tests (At MSL Level 3)	SAT		Lot 2	320		
	Bake 125℃, 24hrs			320		
	30 ℃/60%RH Moisture Soak 192hrs			320		
	3x Convection-Reflow 265 ℃ max			320		
	SAT			320		
	Electrical Test :+25 ℃ and +85 ℃			320	PASS	

	PACKAGE QUALIFICATION REPORT									
Test Number	Test Condition	Standard/	Qty.	Def/SS.	Result	Remarks				
(Reference)		Method	(Acc.)							
	Stress Condition:	JESD22-A104		231		Parts had been pre-conditioned at				
Tomp Cyclo	-65 °C to +150 °C, 1000 Cycles					260℃				
Temp Cycle	Electrical Test: + 25 ℃, + 85 ℃		231 (0)	0/231	Pass	77 units / lot				
BIAS HAST	Stress Condition: +130 °C/85%RH, 96hrs, 192hrs.	JESD22-A110		231		Parts had been pre-conditioned at 260 ℃				
	Electrical Test: + 25 °C, + 85 °C		231 (0)	0/231	Pass	77 units / lot				
uHAST	Stress Condition: +130 °C/85%RH, 96hrs, 192hrs.	JESD22-A110		231		Parts had been pre-conditioned at 260 ℃				
uliAST	Electrical Test: + 25 °C, + 85 °C		231 (0)	0/231	Pass	77 units / lot				
High	Stress Condition:	JESD22-A103		231		Parts had no Pre-Condition				
Temperature Storage Life	Bake +150 °C, 1008hrs					77 units / lot				
	Electrical Test: +25°C, +85°C		231 (0)	0/231	Pass	55 , .55				